

## 19074 PAN File Report: Jinko Solar JKM260P-60 Module

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### 1 Project Summary

CFV Solar conducted PAN file testing on one **JKM260P-60** module produced by **Jinko Solar**. I-V curves at multiple irradiance and temperature conditions were obtained on one sample per IEC 61853-1:2011. The PVsyst 6 single-diode model coefficients were derived with PANOpt®, a software developed at CFV.

### 2 Executive Summary of Results

The performance matrix data were scaled to prepare PAN file source data for the 260 W power class of the JKM260P-60 type. The “Measured STC” scaling method (explained in Procedures section) was used. Optimized PAN files were created for the specified module type and power class with PANOpt®, CFV’s proprietary software.

## Table of Contents

1	Project Summary.....	1
2	Executive Summary of Results .....	1
	Disclaimer and Conditions of Report Reproduction.....	2
3	Sample Information .....	3
4	Procedures .....	5
4.1	Electroluminescence Imaging.....	5
4.2	Preconditioning .....	5
4.3	MQT 06.1 Performance at STC.....	5
4.4	Performance Matrix .....	6
4.5	MQT 04 Temperature Coefficients .....	8
4.6	Performance Data Scaling.....	8
4.7	PAN file Generation and Optimization.....	8
5	Results.....	9
5.1	Electroluminescence Imaging.....	9
5.2	Preconditioning .....	9
5.3	MQT 06.1 Performance at STC.....	10
5.4	MQT 04 Temperature Coefficients.....	10
5.5	Performance Matrix .....	12
5.6	Performance Matrix Data Scaling .....	13
5.7	PAN file Generation and Optimization.....	14

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### 3 Sample Information

Other samples were also tested as part of project 19074. For full information on all samples, refer to reports 19074-PR-E-001 through 19074-PR-E-009.

#### Labeling

Module ID	SNL ID	Manufacturer	Module Type	Serial Number
19074-004	00003562	Jinko Solar	JKM260P-60	19054150712110033352715

#### Constructional Details

Module Type	Length [m]	Width [m]	Thickness [mm]
JKM260P-60	1.650	0.992	40

#### Nameplate Values

Module Type	Isc [A]	Voc [V]	Imp [A]	Vmp [V]	Pmp [W]	Max Sys Volt [V]	Fuse Rating [A]
JKM260P-60	8.98	38.1	8.37	31.1	260	1000	15

#### Photographs

Front



Back



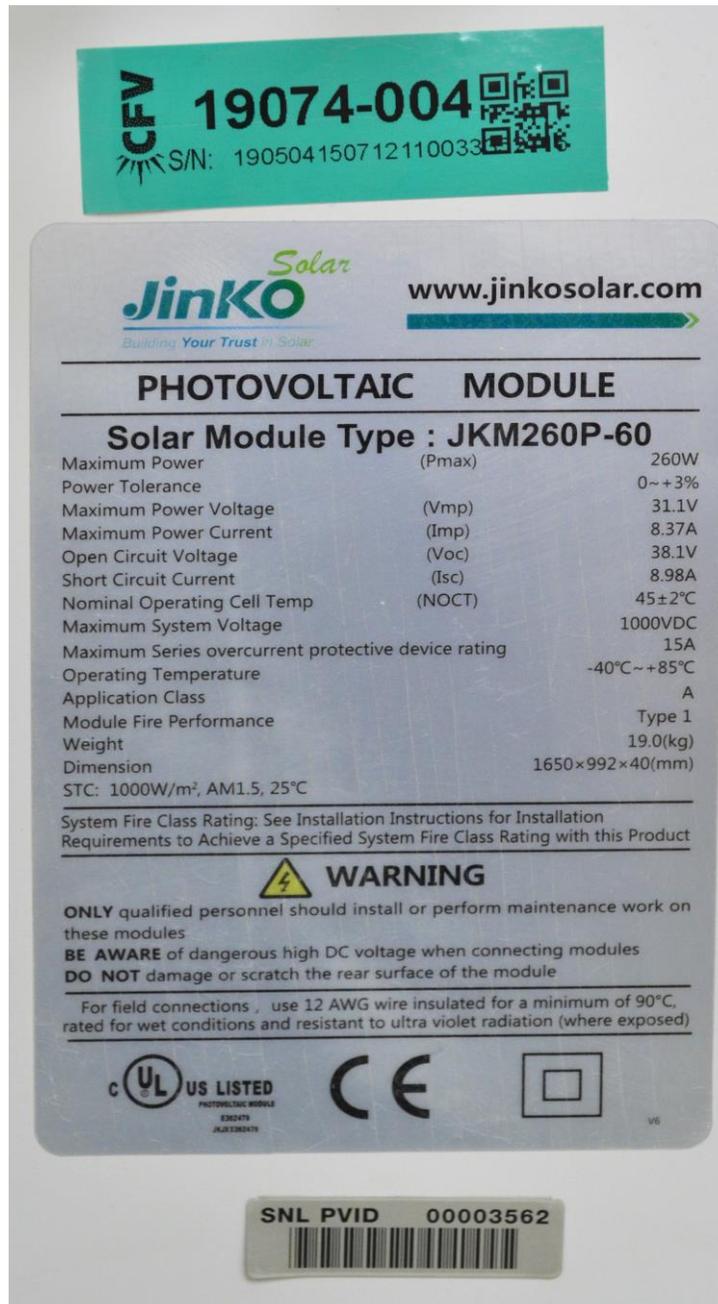
Connectors



Junction Box



## Nameplate(s)



## Sampling

A single fielded sample of the type, JKM260P-60, was tested for this project and used in the PAN file creation.

## 4 Procedures

There were other tests included in project 19074. This report includes only the procedures relevant to the PAN file generation and Electroluminescence Imaging.

### 4.1 Electroluminescence Imaging

Electroluminescence (EL) images were taken with a Peltier-cooled CCD camera that has a resolution of 8.3 MPixels. A long pass filter blocked incoming light with wavelength below 850 nm. A constant DC bias was applied to the modules while the imaging was performed in the dark.

A relevant IEC document (IEC TS 60904-13:2018) has been published recently. The EL imaging was carried out at  $1.0 \times I_{sc}$  per a procedure in this document, but this test is not yet included in CFV's scope of ISO 17025 accreditation.

### 4.2 Preconditioning

The sample was installed outdoors on a fixed rack in open circuit to receive a minimum of 40 kWh/m<sup>2</sup> of irradiation. The plane-of-array irradiance was measured with a calibrated pyranometer. CFV is ISO 17025-accredited to carry out Preconditioning per IEC 61215:2005. The preconditioning carried out for this project deviated from IEC 61215:2005 in that a higher irradiation dose was received (IEC 61215:2005 specifies a dose of 5.0 to 5.5 kWh/m<sup>2</sup>).

### 4.3 MQT 06.1 Performance at STC

Performance at STC test was carried out in conformity with IEC 61215-2:2016 MQT 06.1. CFV is ISO 17025-accredited to carry out the test. This test also qualifies as MQT 02 Maximum Power Determination.

We used a pulse-type solar simulator (Halm moduleTest 3; Fig. 4.3.1), classified as class AAA per IEC 60904-9:2007. The irradiance of the Xenon arc lamp flash at the module plane was measured with a co-planar reference cell (Fraunhofer WPVS type, manufactured by Czibula & Grundmann GmbH) that meets the requirements of IEC 60904-2:2015. The reference cell was calibrated at PTB of Germany. The solar simulator was in a room constantly maintained at  $25 \pm 1^\circ\text{C}$ , and prior to the tests we waited for the modules to thermally stabilize to the room temperature. During the test, the module backside temperature was measured at four points with calibrated RTDs with accuracy better than  $\pm 0.2^\circ\text{C}$ .

The reported I-V characteristics show the average of three consecutive measurements. Each measurement was carried out in conformity with IEC 60904-1:2006. One measurement involved a forward sweep ( $I_{sc}$  to  $V_{oc}$ ) and a reverse sweep ( $V_{oc}$  to  $I_{sc}$ ), whose I-V data were averaged to calculate the  $I_{sc}$ ,  $V_{oc}$ ,  $I_{mp}$ , and  $V_{mp}$  values. The irradiance was controlled to be within  $1000 \pm 3 \text{ W/m}^2$  for the measurements. The minimal differences between the STC and the actual test conditions were further corrected per IEC 60891:2009.

Prior to measurements, testing was carried out to check for I-V curve hysteresis between the forward and reverse sweeps. It was found that the JKM260P-60 module type needed only one section for both the forward and reverse sweeps. The effective sweep time for the measurements on the JKM260P-60 module type was 25 ms forward and 25 ms reverse. A spectral mismatch factor of 1.0 was used as no EQE data was available for this module type.



Fig. 4.3.1 Class AAA solar simulator from h.a.l.m. used at CFV

Table 4.3.1 shows the uncertainty and repeatability of CFV's STC performance data. The values take in to account all the major sources of error, including the reference cell calibration, spectrum of the flasher, non-uniformity of the irradiance in the test plane, etc. CFV maintains a rigorous daily, weekly, and quarterly quality control program to guarantee top-tier flash measurement accuracy. The quarterly control modules are also measured annually at Fraunhofer ISE CalLab of Germany.

#### 4.4 Performance Matrix

Multi-irradiance and multi-temperature Performance Matrix test was conducted in conformity with IEC 61853-1:2011 § 8.1. CFV is ISO 17025-accredited to carry out this test.

The test points cover irradiances from 100 to 1100 W/m<sup>2</sup>, and temperatures from 15 to 75°C. In addition to the test points defined in IEC 61853-1:2011 § 8.1, measurements were obtained at five additional points, as shown in Table 4.4.1. The irradiance was varied by adjusting the voltage applied to the Xenon arc lamp. The spectral match remains class A or better for all irradiances. An integrated thermal chamber varied the module temperature

with a laminar air flow, and the module temperature was monitored at 4 points with calibrated RTDs having uncertainties of  $\pm 0.13^{\circ}\text{C}$ . For each measurement, the max-min temperature spread was less than  $1.5^{\circ}\text{C}$ .

The monitor cell was mounted at a location outside the thermal chamber and was not coplanar with the test module. The monitor cell sensitivity was adjusted to reproduce the Pmp measured at STC on the test module. Other than the irradiance and temperature controls, the measurement procedure was identical to the Performance at STC test.

Table 4.4.1: Test points for the performance matrix. 5 additional test points are indicated.

Irradiance (W/m <sup>2</sup> )	Temperature			
	15°C	25°C	50°C	75°C
1100		⊙	⊙	⊙
1000	⊙	⊙	⊙	⊙
800	⊙	⊙	⊙	⊙
600	⊙	⊙	⊙	⊙
400	⊙	⊙	⊙	⊗
200	⊙	⊙	⊗	⊗
100	⊙	⊙	⊗	⊗

⊙ Measured and required by the IEC 61853-1 standard

⊗ Additional test points; Measured but not required by the IEC 61853-1 standard

## 4.5 MQT 04 Temperature Coefficients

Temperature Coefficients test was conducted in conformity with IEC 61215-2:2016 MQT 04 and IEC 60891:2009 § 4. CFV Solar is ISO 17025-accredited to carry out the test.

The test was carried out along with the Performance Matrix test. In addition to the 15, 25, 50, and 75°C temperatures required for the matrix, the modules were flashed with 1000 W/m<sup>2</sup> irradiance at additional intermediate temperatures. The temperature coefficients for I<sub>sc</sub>, V<sub>oc</sub>, I<sub>mp</sub>, V<sub>mp</sub>, and P<sub>mp</sub> were determined by linear regression over the 15-75°C temperature range.

## 4.6 Performance Data Scaling

When creating PAN files for PVsyst, one requirement is that the P<sub>mp</sub> at STC needs to match the nameplate power. This requirement translates into the technical issues of (1) how to scale the P<sub>mp</sub> values at the various temperature and irradiance points and (2) how to scale the STC I<sub>sc</sub>, V<sub>oc</sub>, I<sub>mp</sub>, and V<sub>mp</sub> values, if the measured values at STC do not match the nameplate values.

In this project, we scaled the performance matrix data for use with PANOpt®, by the following approach:

### Measured STC Approach

<b>Pmp</b>	A constant gain factor was applied to the P <sub>mp</sub> values in the matrix, to obtain the nameplate rating at STC. The gain factor used was: $[Pmp\ Gain] = [NP\ Pmp] / [Measured\ STC\ Pmp]$
<b>Isc, Voc, Imp, Vmp</b>	A constant gain factor equal to the square root of [Pmp Gain] was applied to the I <sub>sc</sub> , V <sub>oc</sub> , I <sub>mp</sub> , and V <sub>mp</sub> values. $[Isc\ Gain] = [Voc\ Gain] = [Imp\ Gain] = [Vmp\ Gain] = [Pmp\ Gain]^{1/2}$

## 4.7 PAN file Generation and Optimization

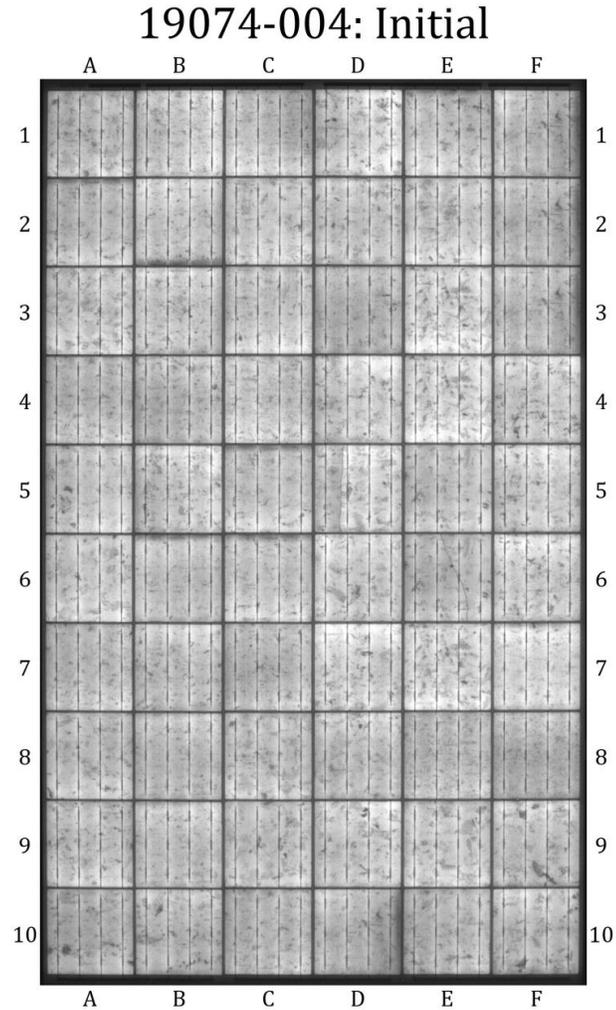
Optimized PAN files were prepared using PANOpt®, an in-house-developed software for deriving from the test data optimum solutions for the PVsyst 6 single-diode performance model. Starting with the measured values of I<sub>sc</sub>, V<sub>oc</sub>, I<sub>mp</sub>, V<sub>mp</sub>, mu<sub>lsc</sub>, and an R<sub>s</sub> value calculated from the I-V curves with the Swanson method, the PANOpt® solver iterated over a given parameter space for R<sub>s</sub>, R<sub>sh</sub>, R<sub>shG0</sub> (and di<sup>2</sup>/μτ<sub>eff</sub> for thin-film technologies) until the PVsyst 6 model-predicted P<sub>mp</sub> values over the Performance Matrix points matched the measured values (average of three samples) with minimum error.

The IAM profile of the test module was not experimentally determined. The default PVsyst IAM profile for normal glass was adopted.

## 5 Results

### 5.1 Electroluminescence Imaging

The module was imaged in the dark while a constant DC bias current of 8.98 A ( $I_{sc}$ ) was applied to the module.



### 5.2 Preconditioning

The module received 41.33 kWh/m<sup>2</sup> of outdoor preconditioning prior to indoor performance testing. The preconditioning was performed with the module in open circuit.

## 5.3 MQT 06.1 Performance at STC

The following values were measured after preconditioning and prior to the Performance Matrix test.

Module ID	Isc [A]	Voc [V]	Imp [V]	Vmp [V]	Pmp [W]	FF [%]
19074-004	8.988	37.70	8.436	30.64	258.52	76.29

Table 5.3.1 Uncertainty and repeatability of flash measurements on Si modules

	Isc	Voc	Imp	Vmp	Pmp
<b>Uncertainty</b>	± 1.8 %	± 0.7 %	± 2.2 %	± 1.3 %	± 2.2 %
<b>Repeatability</b>	± 0.20 %	± 0.20 %	± 0.30 %	± 0.40 %	± 0.45 %

## 5.4 MQT 04 Temperature Coefficients

### Relative Units

Module ID	$\alpha$ Isc [%/°C]	$\beta$ Voc [%/°C]	$\alpha$ Imp [%/°C]	$\beta$ Vmp [%/°C]	$\delta$ Pmp [%/°C]
19074-004	+0.0377	-0.3119	-0.0151	-0.4098	-0.4220

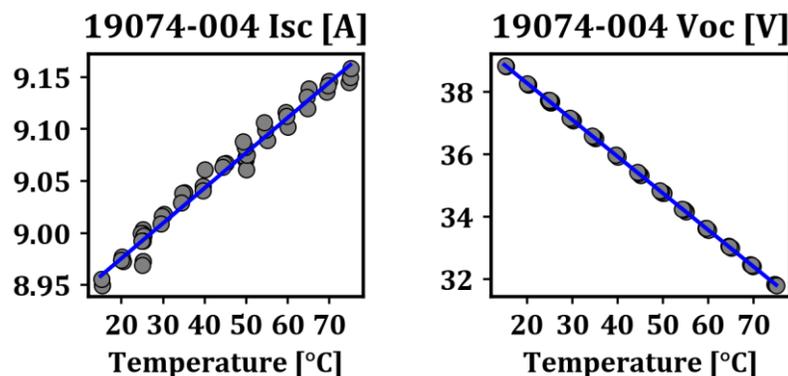
### Absolute Units

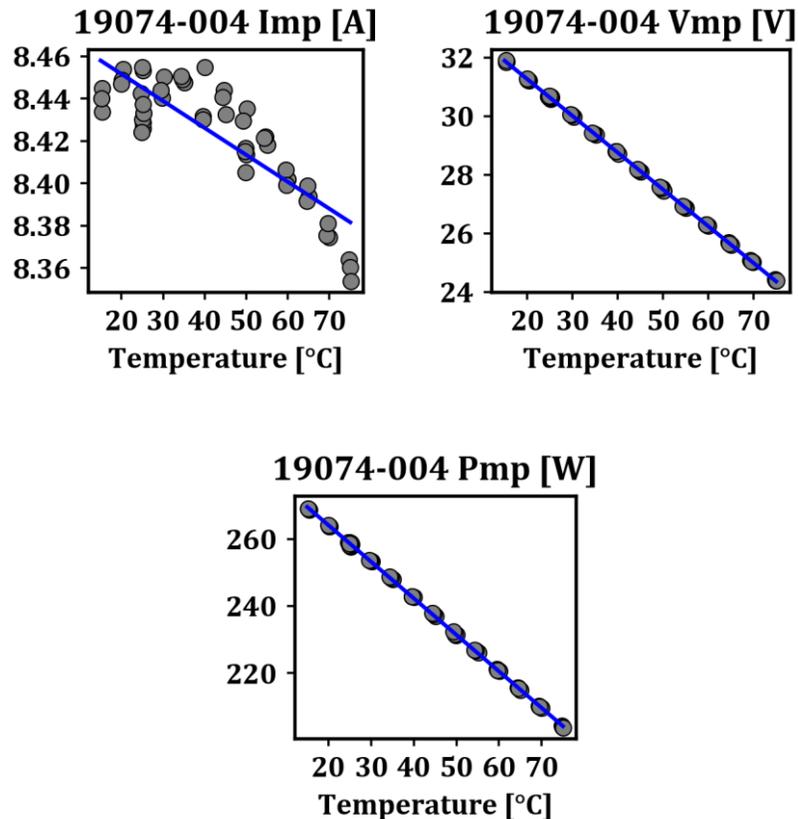
Module ID	$\alpha$ Isc [A/°C]	$\beta$ Voc [V/°C]	$\alpha$ Imp [A/°C]	$\beta$ Vmp [V/°C]	$\delta$ Pmp [W/°C]
19074-004	+0.00339	-0.1176	-0.00127	-0.1255	-1.0916

Table 5.4.1 Estimated uncertainty of temperature coefficients (relative)

	$\alpha$ Isc	$\beta$ Voc	$\alpha$ Imp	$\beta$ Vmp	$\gamma$ Pmp
<b>Uncertainty (k = 2)</b>	± 10 %	± 5 %	N/A	N/A	± 5 %

### Plots





## Measured Data

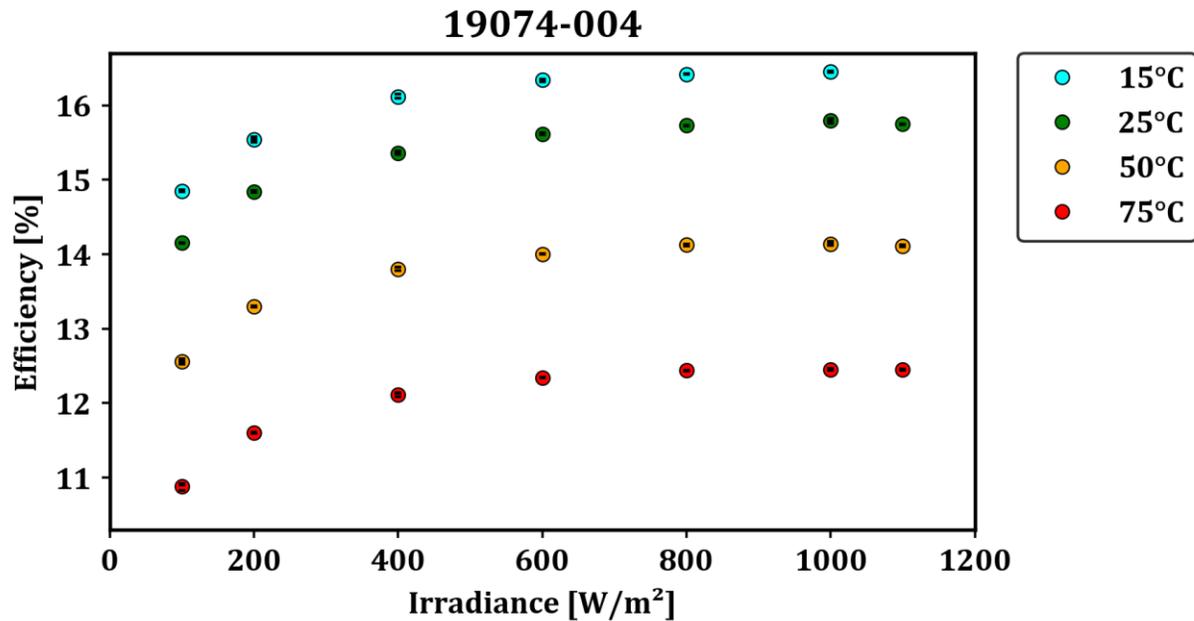
The following table shows the I-V values measured on the tested sample.

Module ID	T (°C)	G (W/m <sup>2</sup> )	Isc (A)	Voc (V)	Imp (A)	Vmp (V)	Pmp (W)
19074-004	15.33	1000	8.952	38.82	8.440	31.87	268.98
19074-004	20.15	1000	8.975	38.26	8.450	31.24	263.94
19074-004	25.07	1000	8.989	37.69	8.437	30.64	258.47
19074-004	29.84	1000	9.014	37.12	8.445	30.02	253.51
19074-004	34.71	1000	9.036	36.55	8.449	29.40	248.38
19074-004	39.75	1000	9.049	35.96	8.439	28.77	242.76
19074-004	44.71	1000	9.066	35.38	8.439	28.14	237.51
19074-004	49.77	1000	9.075	34.78	8.419	27.51	231.59
19074-004	54.67	1000	9.099	34.22	8.420	26.90	226.51
19074-004	59.73	1000	9.110	33.62	8.402	26.28	220.82
19074-004	64.72	1000	9.130	33.03	8.395	25.65	215.32
19074-004	69.63	1000	9.141	32.44	8.377	25.04	209.80
19074-004	74.91	1000	9.151	31.82	8.359	24.39	203.91

## 5.5 Performance Matrix

### Efficiency Curves

In the following plot, circles indicate the average of three measurements at each irradiance and temperature test condition. Bars inside the circles indicate the values from each of the three measurements.



### Measured Data

The following table shows the Performance Matrix data measured on the tested sample.

Module ID	T (°C)	G (W/m <sup>2</sup> )	Isc (A)	Voc (V)	Imp (A)	Vmp (V)	Pmp (W)
19074-004	15	100	0.882	34.88	0.819	29.67	24.31
19074-004	15	200	1.767	36.08	1.657	30.69	50.87
19074-004	15	400	3.540	37.28	3.348	31.52	105.52
19074-004	15	600	5.341	37.98	5.043	31.82	160.46
19074-004	15	800	7.139	38.47	6.737	31.91	214.99
19074-004	15	1000	8.951	38.87	8.439	31.90	269.22
19074-004	25	100	0.885	33.54	0.820	28.26	23.17
19074-004	25	200	1.770	34.79	1.654	29.36	48.58
19074-004	25	400	3.550	36.03	3.332	30.18	100.56
19074-004	25	600	5.351	36.75	5.031	30.48	153.37
19074-004	25	800	7.160	37.27	6.728	30.61	205.98
19074-004	25	1000	8.988	37.70	8.436	30.64	258.52
19074-004	25	1100	9.876	37.85	9.272	30.58	283.57
19074-004	50	100	0.897	30.33	0.821	25.03	20.56

Module ID	T (°C)	G (W/m <sup>2</sup> )	Isc (A)	Voc (V)	Imp (A)	Vmp (V)	Pmp (W)
19074-004	50	200	1.792	31.66	1.665	26.15	43.53
19074-004	50	400	3.595	32.99	3.343	27.02	90.34
19074-004	50	600	5.412	33.77	5.031	27.33	137.51
19074-004	50	800	7.237	34.33	6.732	27.47	184.94
19074-004	50	1000	9.076	34.76	8.420	27.49	231.45
19074-004	50	1100	9.976	34.94	9.251	27.47	254.08
19074-004	75	100	0.908	27.00	0.819	21.76	17.82
19074-004	75	200	1.814	28.44	1.658	22.91	37.98
19074-004	75	400	3.632	29.89	3.330	23.82	79.33
19074-004	75	600	5.465	30.74	5.008	24.20	121.21
19074-004	75	800	7.305	31.34	6.691	24.35	162.90
19074-004	75	1000	9.151	31.81	8.360	24.39	203.86
19074-004	75	1100	10.069	32.01	9.197	24.37	224.11

## 5.6 Performance Matrix Data Scaling

The gain factors were calculated as explained in the procedures section.

*Measured STC values of the single test module*

Measured Power Class	Measured STC Isc (A)	Measured STC Voc (V)	Measured STC Imp (A)	Measured STC Vmp (V)	Measured STC Pmp (W)
260	8.988	37.70	8.436	30.64	258.52

*Applied gain factors for PAN file STC values by power class*

PAN File Power Class	Isc Gain	Voc Gain	Imp Gain	Vmp Gain	Pmp Gain
260	1.0029	1.0029	1.0029	1.0029	1.0057

*PAN file STC values by power class*

PAN File Power Class	PAN File STC Isc (A)	PAN File STC Voc (V)	PAN File STC Imp (A)	PAN File STC Vmp (V)
260	9.014	37.81	8.461	30.73

## 5.7 PAN file Generation and Optimization

### PAN File Parameters for 260 W Class

Tab	Parameter	260 W
Basic data	Model	JKM260P-60
	Manufacturer	Jinko Solar
	File name	Jinko Solar_JKM260P-60_Dec2019_CFV.PAN
	Data source	CFV Solar Test Lab - Tested Class
	Nom. Power (Wp)	260
	Tol. - (%)	0
	Tol. + (%)	3
	Technology	Si-poly
	GRef (W/m2)	1000
	TRef (°C)	25
	Isc (A)	9.014
	Voc (V)	37.81
	Imp (A)	8.461
	Vmpp (V)	30.73
mulsc (%/°C)	0.038	
Sizes and Technology	Length (mm)	1650
	Width (mm)	992
	Thickness (mm)	40
	Cells in series	60
	Maximum voltage IEC (V)	1000
	Maximum voltage UL (V)	1000
	Nb. of sub-modules	3
	Sub-module partition	Full Cells
Model parameters / Rshunt - Rserie	Rsh (Ohm)	268
	Rs (Ohm)	0.248
Model parameters / RShunt expon.	Rshunt at Ginc = 0 (Ohm)	744
	Exponential parameter	5.5
Model parameters / Temper. coeff	Apply Temperature Correction on Gamma	Checked
	Pmpp temper. Coeff <sup>1</sup>	-0.418
Additional data /	Special IAM defined for this module	Unchecked

<sup>1</sup> The Pmp temperature coefficient in PVsyst is different from the definition in IEC 60891:2009. In PVsyst, the Pmp temperature coefficient is calculated from the Pmp values at 25°C and 45°C. Per IEC 60891:2009, the Pmp temperature coefficient is to be calculated by a linear fit through Pmp values measured over a temperature range greater than or equal to 30°C. There is in fact some nonlinearity in the Pmp dependence on temperature, which is why the Pmp temperature coefficient value for the PAN file is different from the value reported in Section 04.

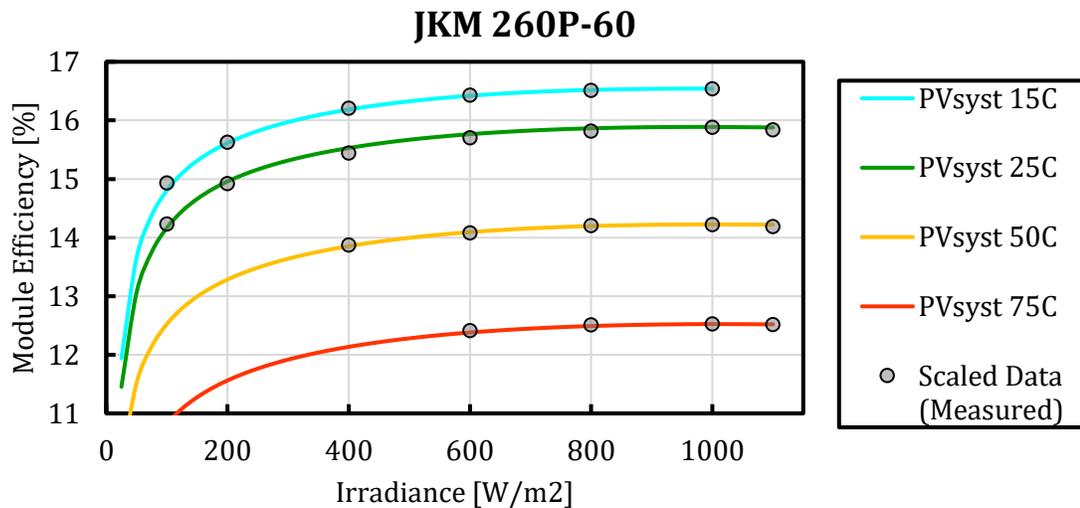
Tab	Parameter		260 W
Customized IAM	Front Surface		Normal Glass
	Point 1	0°	1.000
	Point 2	30°	0.998
	Point 3	50°	0.981
	Point 4	60°	0.948
	Point 5	70°	0.862
	Point 6	75°	0.776
	Point 7	80°	0.636
	Point 8	85°	0.403
	Point 9	90°	0.000

### PAN File Model Accuracy

PVsyst 6 model output was compared with the scaled data used as the PANOpt® input.

Power Class	RMS Error of Pmp (Error = PVsyst 6 model Pmp - Measured Pmp) [W]				
	15-75°C	15°C	25°C	50°C	75°C
260 W	0.32	0.12	0.48	0.25	0.20

Module Type	RMS Error of Eff. (Error = PVsyst 6 model Eff. - Measured Eff.) [%p]				
	15-75°C	15°C	25°C	50°C	75°C
260 W	0.043	0.053	0.054	0.018	0.018



--END OF REPORT--